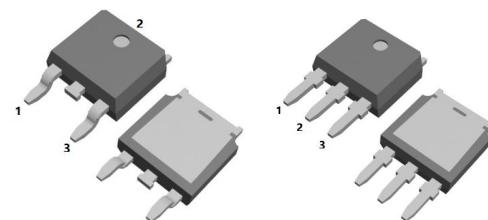
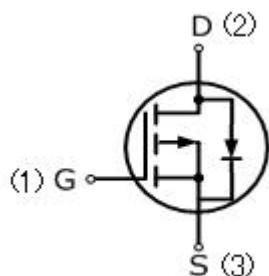


## 85P03(G,D)L

-85 Amps,-30 Volts P-CHANNEL MOSFET

### FEATURE

- -85A,-30V, $R_{DS(ON)MAX}=8m\Omega$  @ $V_{GS}=-10V/-10A$   
 $R_{DS(ON)MAX}=11m\Omega$  @ $V_{GS}=-4.5V/-10A$
- Low gate charge
- Low  $C_{iss}$
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability



TO-252-2L

85P03GL

TO-251-3L

85P03DL

### Absolute Maximum Ratings( $T_c=25^\circ C$ ,unless otherwise noted)

Parameter	Symbol	85P03(G,D)L	UNIT
Drain-Source Voltage	$V_{DSS}$	-30	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current	$I_D$	-85	A
Pulsed Drain Current(Note1)	$I_{DM}$	-200	
Single Pulse Avalanche Energy (Note 2)	$E_{AS}$	150	mJ
Operating Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to +150	°C
Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	$T_L$	260	°C

### Thermal Characteristics

Parameter	Symbol	85P03(G,D)L	Units
Thermal resistance , Junction to Case	$R_{th(J-c)}$	1.6	°C/W
Maximum Power Dissipation	$T_c=25^\circ C$	$P_D$	W

**Electrical Characteristics (T<sub>c</sub>=25°C,unless otherwise noted)**

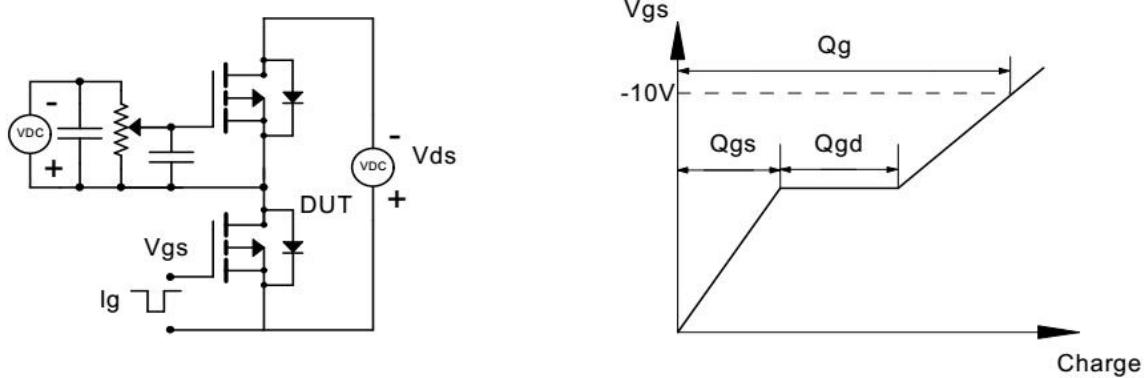
Parameter	Symbol	Test Conditions	Min	Typ	Max	Units
<b>Off Characteristics</b>						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V,I <sub>D</sub> =-250uA	-30	—	—	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-30V,V <sub>GS</sub> =0V	—	—	-1	uA
Gate-Body Leakage Current,Forward	I <sub>GSSF</sub>	V <sub>GS</sub> =20V,V <sub>DS</sub> =0V	—	—	100	nA
Gate-Body Leakage Current,Reverse	I <sub>GSSR</sub>	V <sub>GS</sub> =-20V,V <sub>DS</sub> =0V	—	—	-100	nA
<b>On Characteristics</b>						
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> =V <sub>GS</sub> ,I <sub>D</sub> =-250uA	-1.0	—	-2.5	V
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> =-10V,I <sub>D</sub> =-10A	—	6	8	mΩ
		V <sub>GS</sub> =-4.5V,I <sub>D</sub> =-10A	—	9	11	
<b>Dynamic Characteristics</b>						
Input Capacitance	C <sub>iss</sub>	V <sub>DS</sub> =-25V,V <sub>GS</sub> =0V, f=1.0MHZ	—	2303	—	pF
Output Capacitance	C <sub>oss</sub>		—	316	—	pF
Reverse Transfer Capacitance	C <sub>rss</sub>		—	287	—	pF
<b>Switching Characteristics</b>						
Turn-On Delay Time	t <sub>d(on)</sub>	V <sub>DD</sub> =-15V,I <sub>D</sub> =-20A, V <sub>GS</sub> =-10V, R <sub>G</sub> =3.7Ω	—	12	—	ns
Turn-On Rise Time	t <sub>r</sub>		—	4	—	ns
Turn-Off Delay Time	t <sub>d(off)</sub>		—	67	—	ns
Turn-Off Fall Time	t <sub>f</sub>		—	37	—	ns
Total Gate Charge	Q <sub>g</sub>	V <sub>DS</sub> =-15V,V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A	—	61	—	nC
Gate-Source Charge	Q <sub>gs</sub>		—	10	—	nC
Gate-Drain Charge	Q <sub>gd</sub>		—	15	—	nC
<b>Drain-Source Body Diode Characteristics and Maximum Ratings</b>						
Continuous Diode Forward Current	I <sub>s</sub>		—	—	-85	A
Pulsed Diode Forward Current	I <sub>SM</sub>		—	—	-200	A
Diode Forward Voltage	V <sub>SD</sub>	I <sub>s</sub> =-1A,V <sub>GS</sub> =0V	—	—	-1.2	V
Reverse Recovery Time	t <sub>rr</sub>	V <sub>GS</sub> =0V,I <sub>s</sub> =-5A, dI <sub>F</sub> /dt=100A/us,(Note3)	—	25	—	ns
Reverse Recovery Charge	Q <sub>rr</sub>		—	23	—	uC

**Notes**

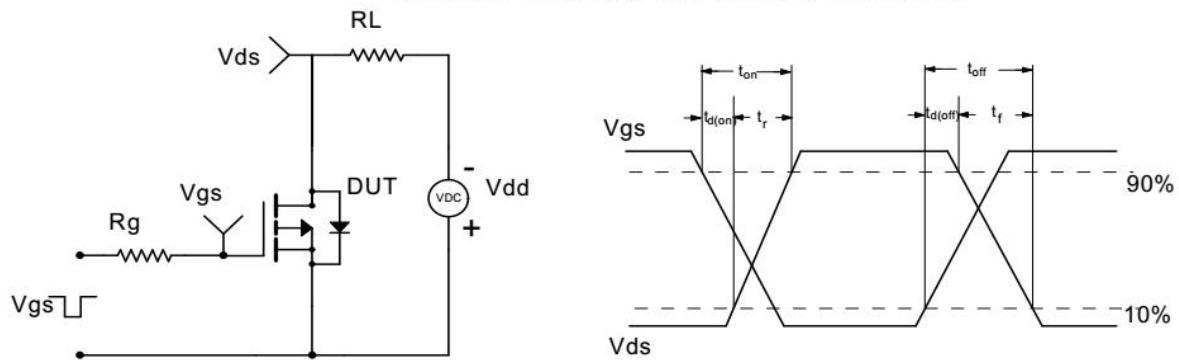
1. Repetitive Rating:pulse width limited by maximum junction temperature .
2. L=0.5mH,R<sub>g</sub>=25Ω , T<sub>J</sub>=25°C.
3. Pulse width≤300us;duty cycle≤2%.

## Test Circuit and Waveform

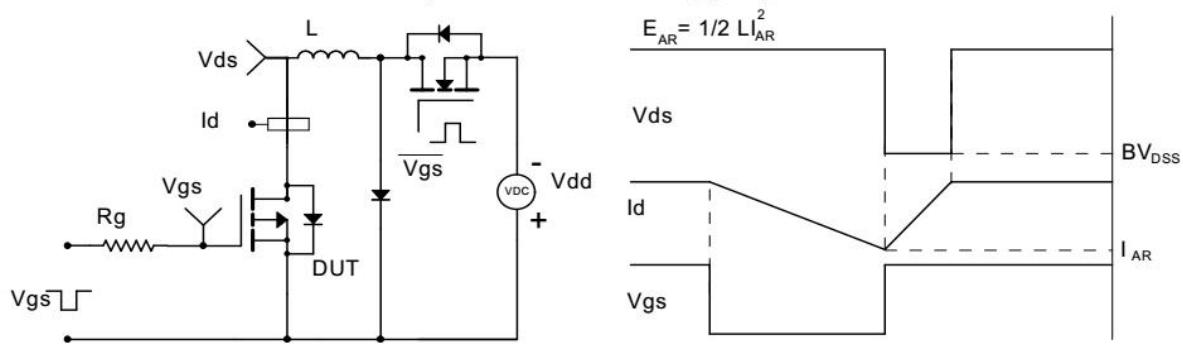
Gate Charge Test Circuit & Waveform



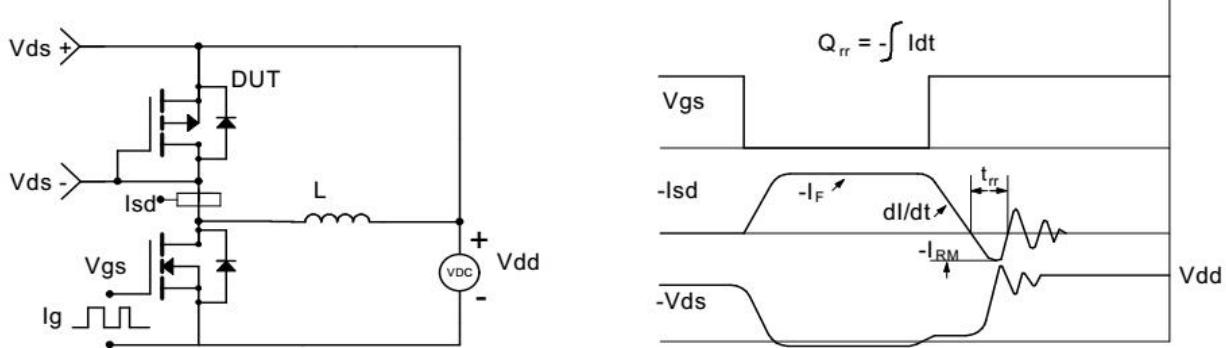
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms



Diode Recovery Test Circuit & Waveforms



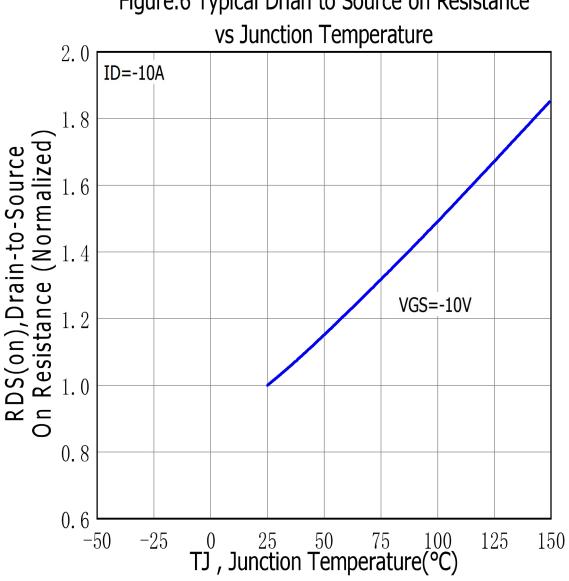
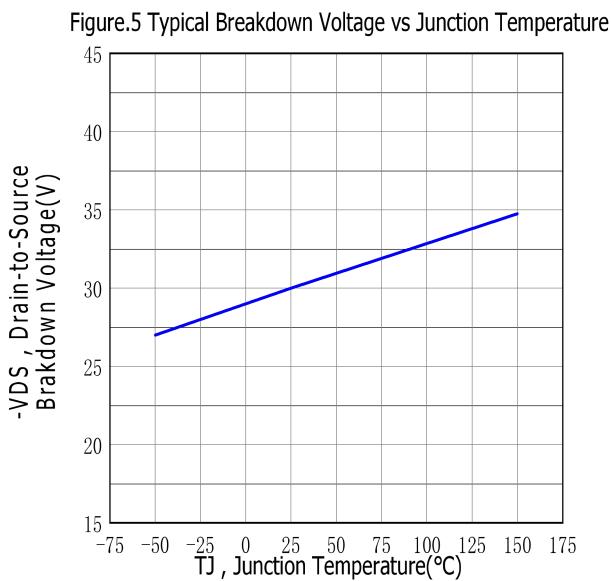
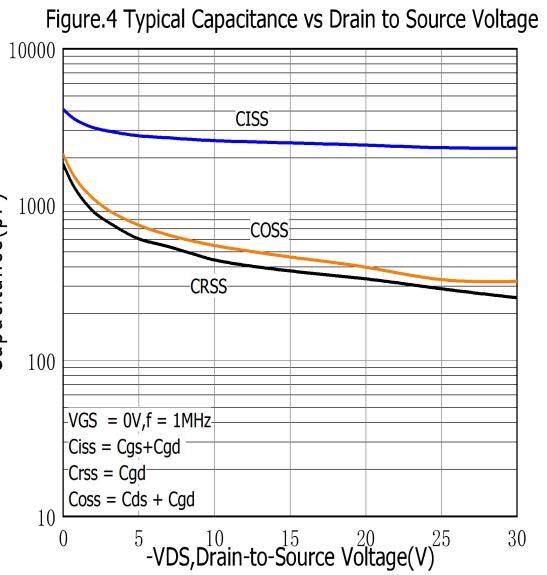
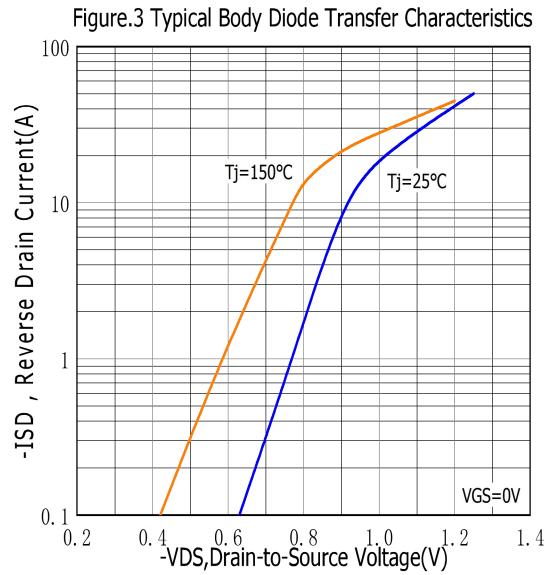
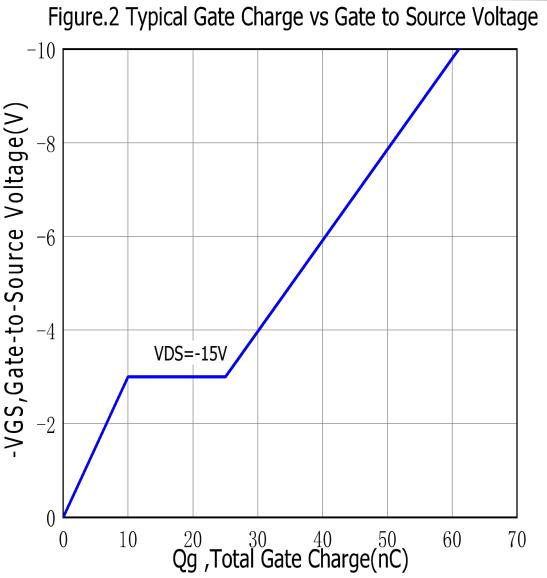
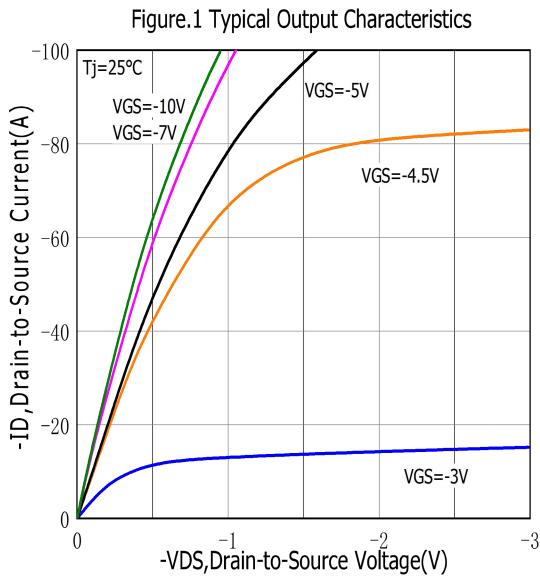


Figure.7 Maximum Forward Bias Safe Operating Area

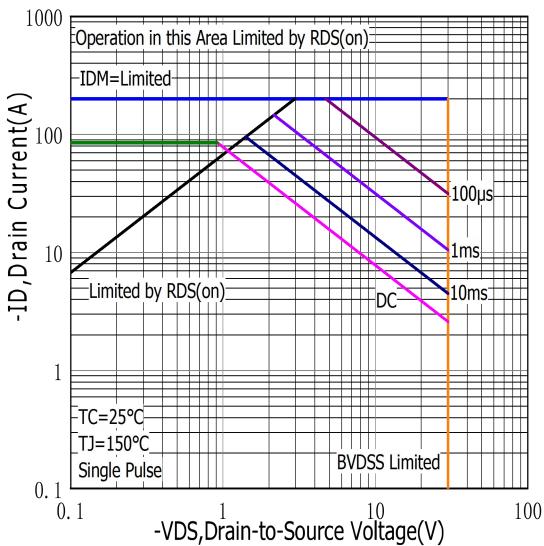


Figure.9 Maximum EAS vs Channel Temperature

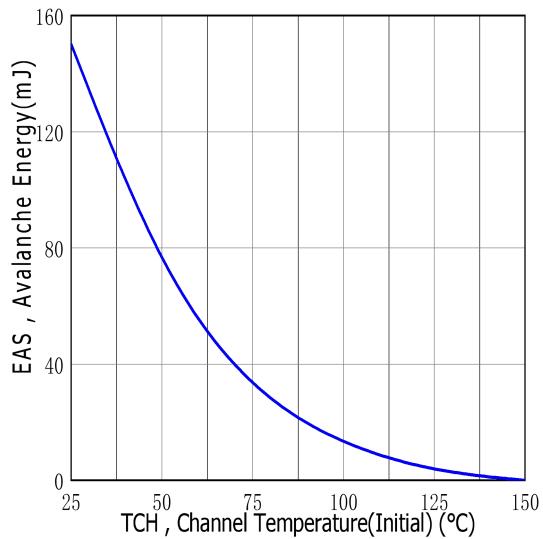


Figure.11 Maximum Effective Thermal Impedance , Junction to Case

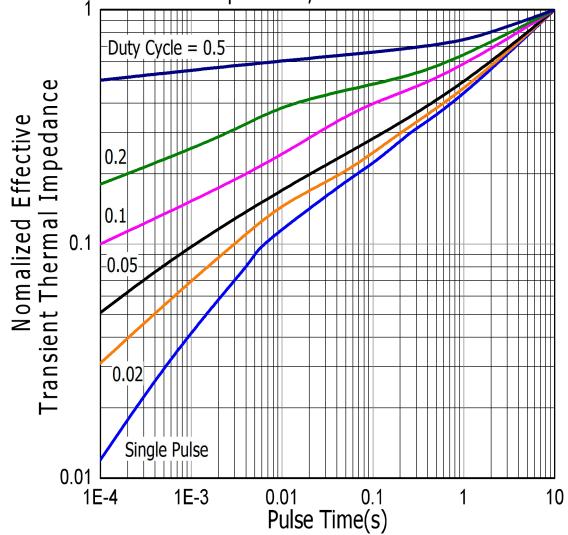


Figure.8 Typical Drain to Source ON Resistance vs Drain Current

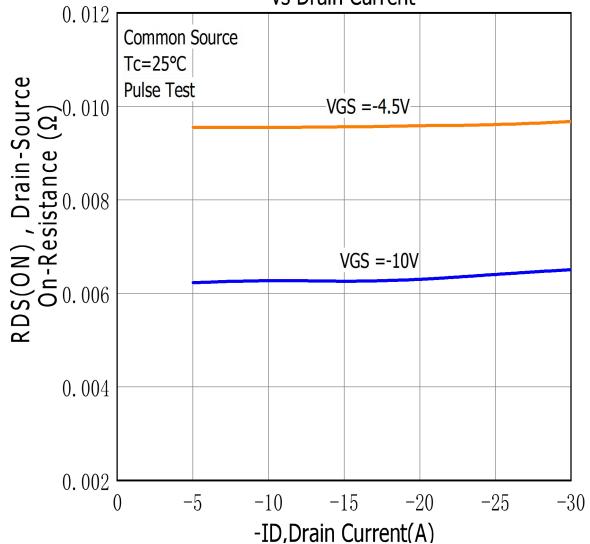


Figure.10 Typical Threshold Voltage vs Case Temperature

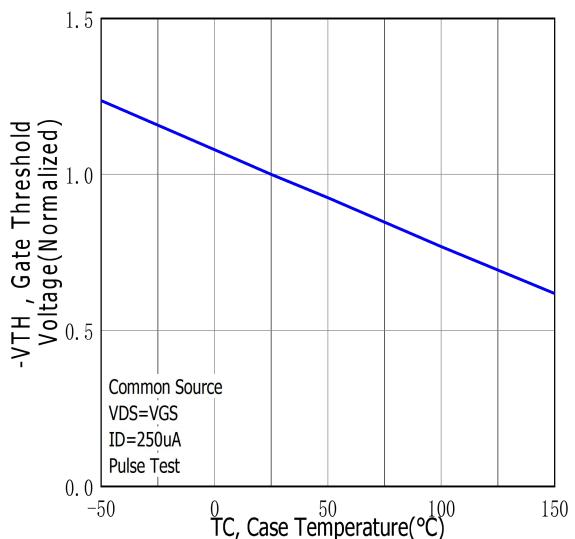
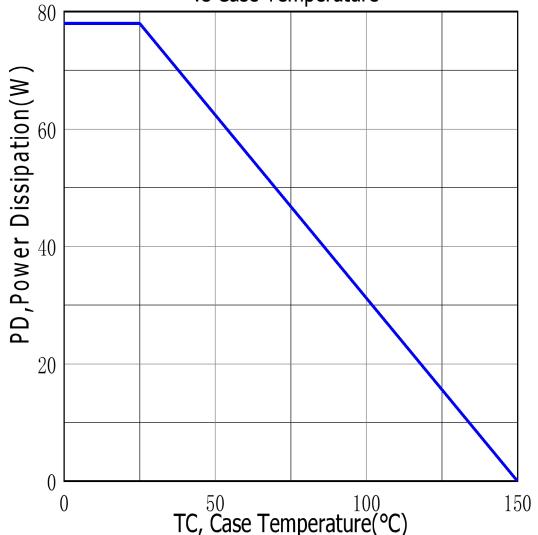
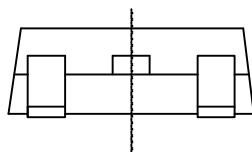
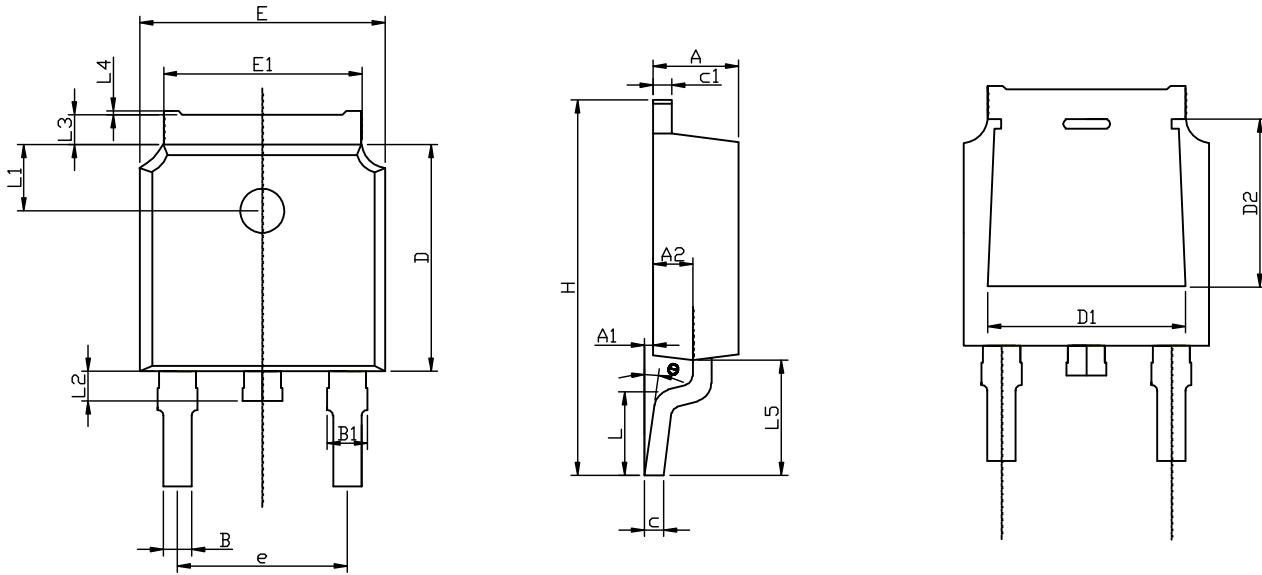


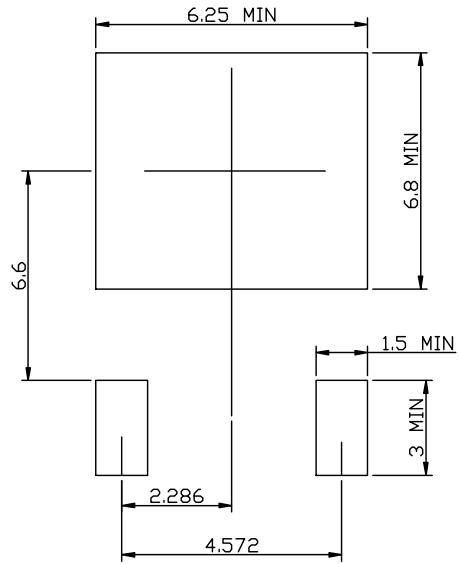
Figure.12 Maximum Power Dissipation vs Case Temperature



## TO-252-2L PACKAGE OUTLINE



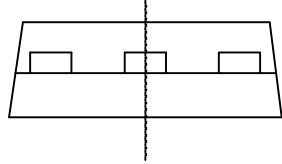
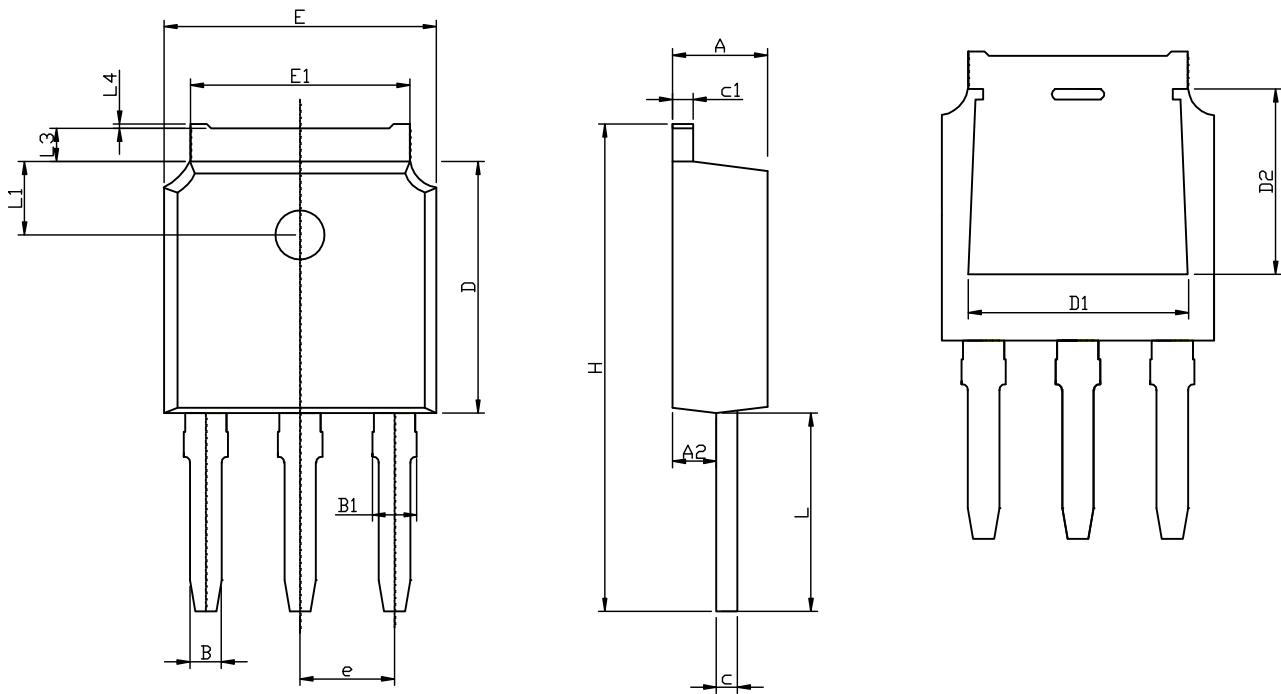
RECOMMENDED LAND PATTERN



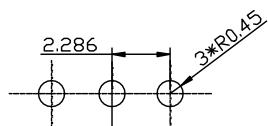
	MIN	NOM	MAX
A	2.15	2.30	2.45
A1	0.05	0.10	0.20
A2	0.91	1.07	1.22
B	0.66	0.76	0.86
B1	0.93	1.08	1.23
C	0.40	0.50	0.60
C1	0.40	0.50	0.60
D	5.95	6.10	6.25
D1	—	4.8REF	—
D2	—	3.8REF	—
E	6.45	6.60	6.75
E1	5.12	5.32	5.52
L		1.65	
L1	1.58	1.78	1.98
L2	0.60	0.80	1.00
L3	0.70	0.85	1.00
L4	0.00	0.05	0.20
L5	2.80	3.10	3.40
H	9.80	10.10	10.40
$\Theta$	0°		8°
e		4.572REF	

UNIT: mm

## TO-251-3L PACKAGE OUTLINE



RECOMMENDED LAND PATTERN



UNIT: mm

	MIN	NOM	MAX
A	2.15	2.30	2.45
A2	0.91	1.07	1.22
B	0.66	0.76	0.86
B1	0.93	1.08	1.23
C	0.40	0.50	0.60
C1	0.40	0.50	0.60
D	5.95	6.10	6.25
D1	—	4.8REF	—
D2	—	3.8REF	—
E	6.45	6.60	6.75
E1	5.12	5.32	5.52
L	4.50	4.80	5.10
L1	1.58	1.78	1.98
L3	0.70	0.85	1.00
L4	0.00	0.05	0.20
H	11.50	11.80	12.10
e		2.286REF	